



ALPHA & OMEGA
SEMICONDUCTOR

AO6411
20V P-Channel AlphaMOS

General Description

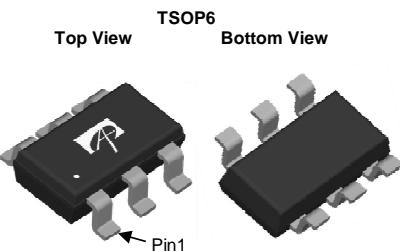
- Trench Power AlphaMOS (α MOS LV) technology
- Low $R_{DS(ON)}$
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

Product Summary

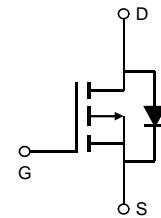
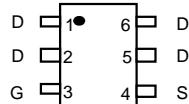
V_{DS}	-20V
I_D (at $V_{GS}=-4.5V$)	-7A
$R_{DS(ON)}$ (at $V_{GS}=-4.5V$)	< 28.5mΩ
$R_{DS(ON)}$ (at $V_{GS}=-2.5V$)	< 36.5mΩ
$R_{DS(ON)}$ (at $V_{GS}=-1.8V$)	< 47 mΩ

Applications

- Load switch
- Battery protection



Top View



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AO6411	TSOP-6	Tape & Reel	3000

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	-20	V
Gate-Source Voltage	V_{GS}	± 8	V
Continuous Drain Current	I_D	-7	A
$T_A=70^\circ\text{C}$		-5.5	
Pulsed Drain Current ^C	I_{DM}	-28	
Power Dissipation ^B	P_D	2.7	W
$T_A=70^\circ\text{C}$		1.7	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	35	45	°C/W
Maximum Junction-to-Ambient ^{A D} Steady-State		60	75	°C/W
Maximum Junction-to-Lead	$R_{\theta JL}$	23	30	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$\text{ID}=-250\mu\text{A}, \text{V}_{\text{GS}}=0\text{V}$	-20			V
I_{DSS}	Zero Gate Voltage Drain Current	$\text{V}_{\text{DS}}=-20\text{V}, \text{V}_{\text{GS}}=0\text{V}$ $\text{T}_J=55^\circ\text{C}$		-1		μA
I_{GSS}	Gate-Body leakage current	$\text{V}_{\text{DS}}=0\text{V}, \text{V}_{\text{GS}}=\pm 8\text{V}$			-5	nA
$\text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_{\text{D}}=-250\mu\text{A}$	-0.3	-0.65	-0.9	V
$\text{R}_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance	$\text{V}_{\text{GS}}=-4.5\text{V}, \text{I}_{\text{D}}=-7\text{A}$ $\text{T}_J=125^\circ\text{C}$		23.5	28.5	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=-2.5\text{V}, \text{I}_{\text{D}}=-3.5\text{A}$		34	41	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=-1.8\text{V}, \text{I}_{\text{D}}=-2.2\text{A}$		29	36.5	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=-1.8\text{V}, \text{I}_{\text{D}}=-2.2\text{A}$		36	47	$\text{m}\Omega$
g_{FS}	Forward Transconductance	$\text{V}_{\text{DS}}=-5\text{V}, \text{I}_{\text{D}}=-7\text{A}$		23		S
V_{SD}	Diode Forward Voltage	$\text{I}_{\text{S}}=-1\text{A}, \text{V}_{\text{GS}}=0\text{V}$		-0.62	-1	V
I_{S}	Maximum Body-Diode Continuous Current				-3.5	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=-10\text{V}, \text{f}=1\text{MHz}$		1025		pF
C_{oss}	Output Capacitance			167		pF
C_{rss}	Reverse Transfer Capacitance			119		pF
R_{g}	Gate resistance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=0\text{V}, \text{f}=1\text{MHz}$		11		Ω
SWITCHING PARAMETERS						
Q_{g}	Total Gate Charge	$\text{V}_{\text{GS}}=-4.5\text{V}, \text{V}_{\text{DS}}=-10\text{V}, \text{I}_{\text{D}}=-7\text{A}$		13	18	nC
Q_{gs}	Gate Source Charge			2		nC
Q_{gd}	Gate Drain Charge			3.4		nC
$\text{t}_{\text{D}(\text{on})}$	Turn-On DelayTime	$\text{V}_{\text{GS}}=-4.5\text{V}, \text{V}_{\text{DS}}=-10\text{V}, \text{I}_{\text{D}}=-7\text{A}$ $\text{R}_{\text{L}}=1.43\Omega, \text{R}_{\text{GEN}}=3\Omega$		10		ns
t_{r}	Turn-On Rise Time			15		ns
$\text{t}_{\text{D}(\text{off})}$	Turn-Off DelayTime			85		ns
t_{f}	Turn-Off Fall Time			40		ns
t_{rr}	Body Diode Reverse Recovery Time	$\text{I}_{\text{F}}=-7\text{A}, \text{di/dt}=500\text{A}/\mu\text{s}$		30		ns
Q_{rr}	Body Diode Reverse Recovery Charge	$\text{I}_{\text{F}}=-7\text{A}, \text{di/dt}=500\text{A}/\mu\text{s}$		80		nC

A. The value of R_{JA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $\text{T}_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $\text{T}_{\text{J}(\text{MAX})}=150^\circ\text{C}$, using $\leq 10\text{s}$ junction-to-ambient thermal resistance.

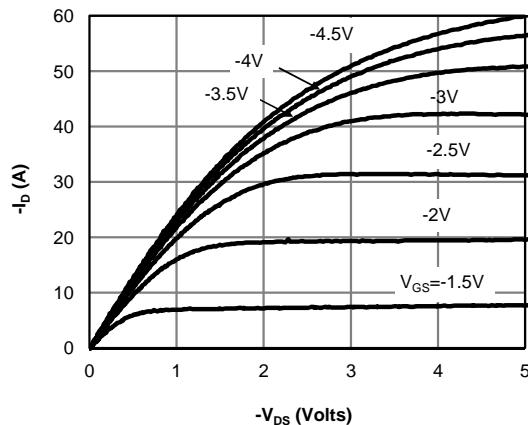
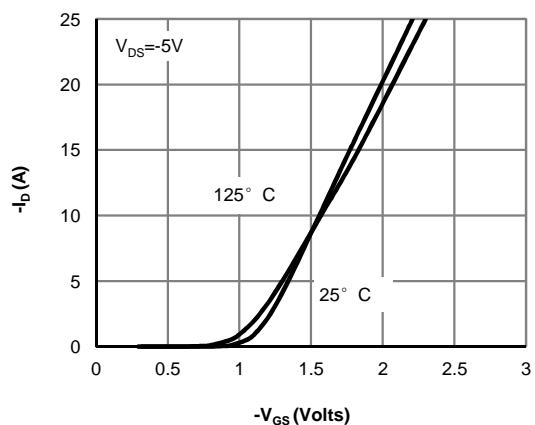
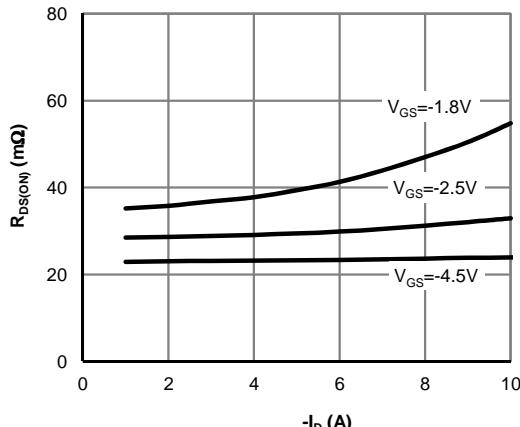
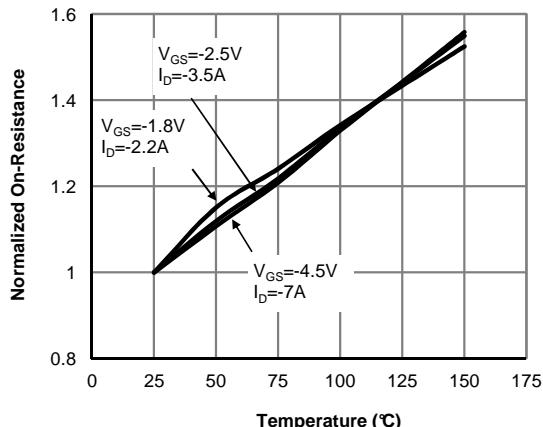
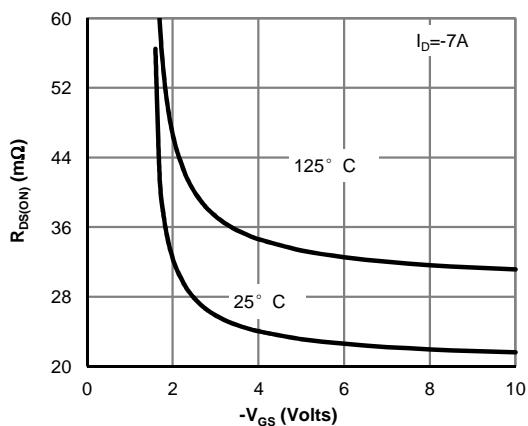
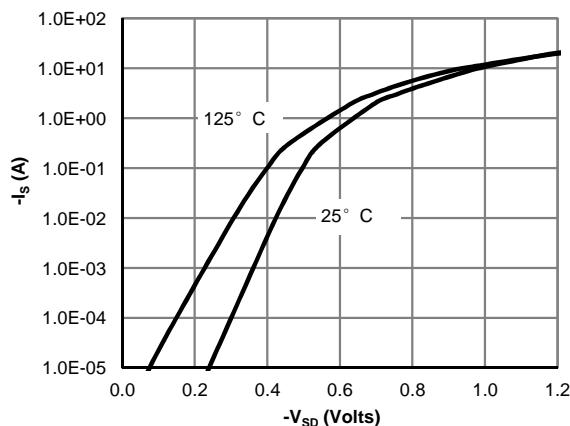
C. Repetitive rating, pulse width limited by junction temperature $\text{T}_{\text{J}(\text{MAX})}=150^\circ\text{C}$. Ratings are based on low frequency and duty cycles to keep initial $\text{T}_J=25^\circ\text{C}$.

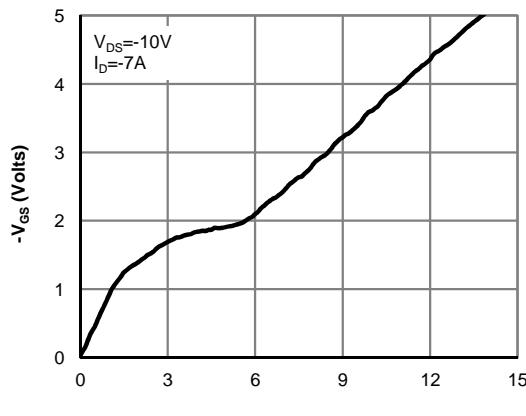
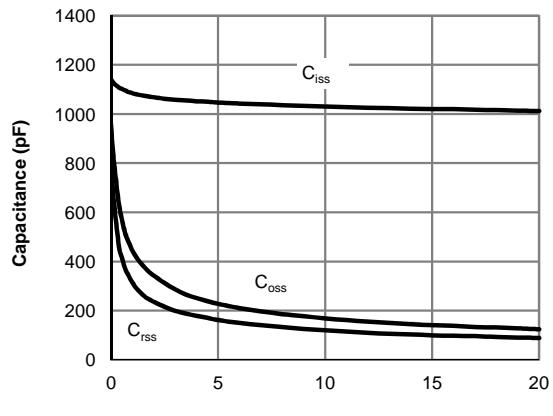
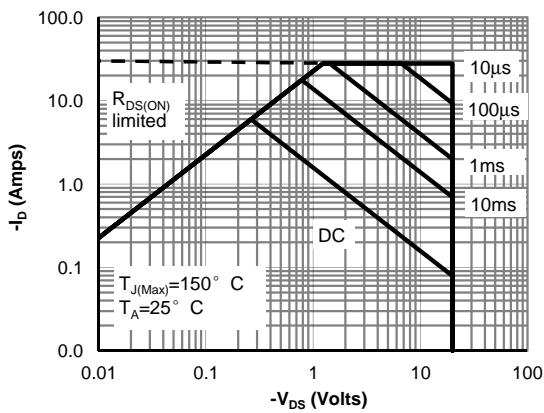
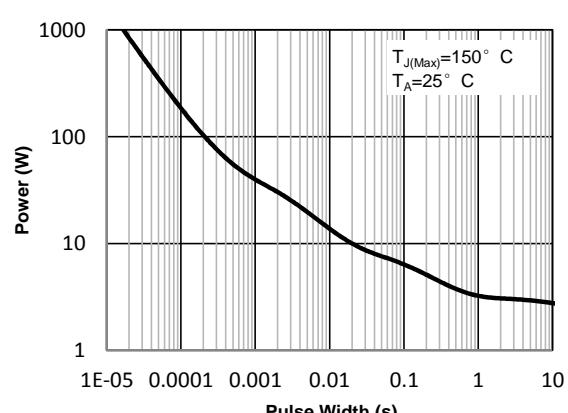
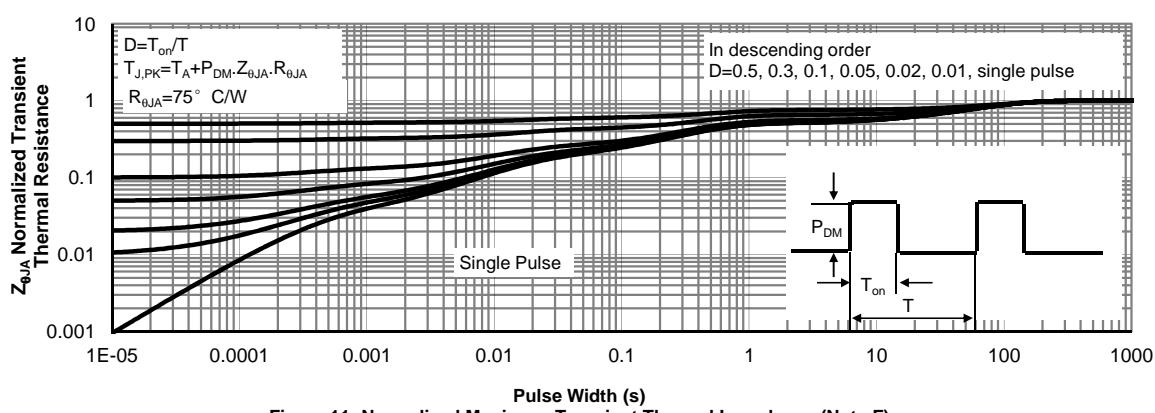
D. The R_{JA} is the sum of the thermal impedance from junction to lead R_{JL} and lead to ambient.

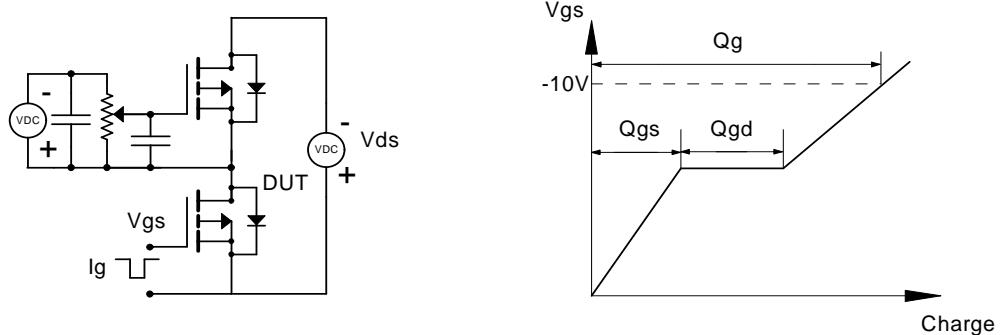
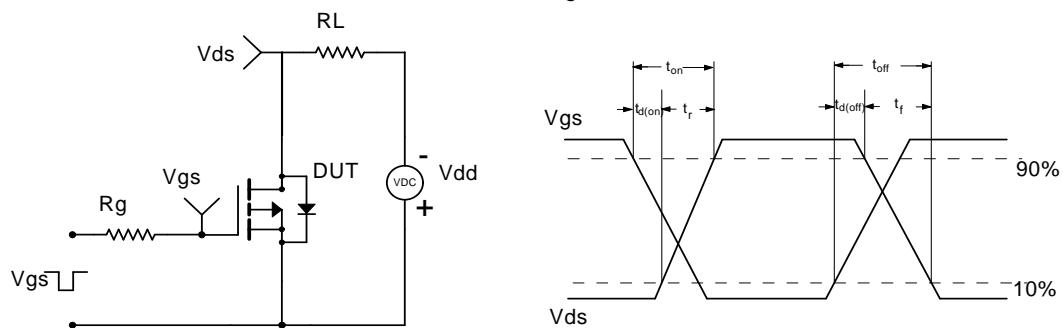
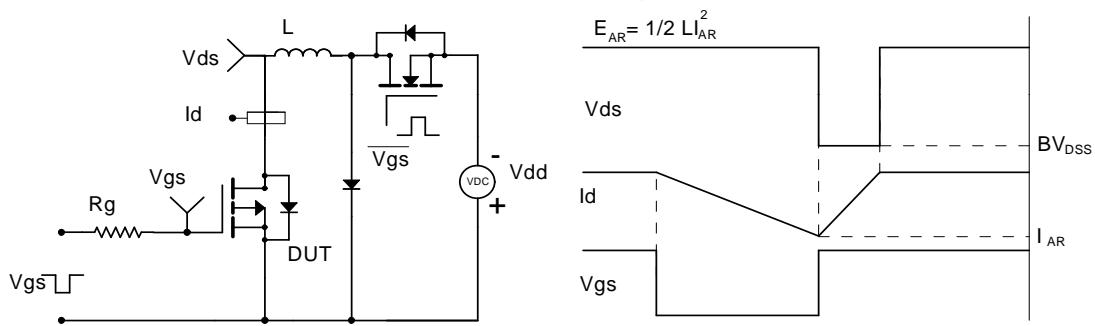
E. The static characteristics in Figures 1 to 6 are obtained using $<300\mu\text{s}$ pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $\text{T}_{\text{J}(\text{MAX})}=150^\circ\text{C}$. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 1: On-Region Characteristics (Note E)

Figure 2: Transfer Characteristics (Note E)

Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

Figure 4: On-Resistance vs. Junction Temperature (Note E)

Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 7: Gate-Charge Characteristics

Figure 8: Capacitance Characteristics

Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

Diode Recovery Test Circuit & Waveforms
